

FCC SAR TEST REPORT

Application No.: SZCR2507003037AT
Applicant: Fujian Newland Payment Technology Co.,Ltd.
Address of Applicant: No. B602, Building #1, Haixia Jingmao Plaza, Fuzhou Bonded Area 350015, Fujian, China
Manufacturer: Fujian Newland Payment Technology Co.,Ltd.
Address of Manufacturer: No. B602, Building #1, Haixia Jingmao Plaza, Fuzhou Bonded Area 350015, Fujian, China
EUT Description: POS Terminal
Model No.: S90
Trade Mark: Newland
FCC ID: 2AM6U-NAS90P
Standards: FCC 47CFR §2.1093
Date of Receipt: 2025-07-20
Date of Test: 2025-07-22 to 2025-08-07
Date of Issue: 2025-08-11

Test Result :	PASS *
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* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Keny Xu

Keny Xu
EMC Laboratory Manager



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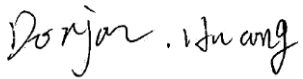
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SZSAR-TRF-01 Rev. A/1

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Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2025-08-11		Original

Authorized for issue by:				
				
		Donjon Huang / Project Engineer		
				
		Roman Pan / Reviewer		



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TEST SUMMARY

Frequency Band	Maximum Reported SAR(W/kg)
	Extremity
LTE Band 7	1.49
LTE Band 12/17	0.79
LTE Band 13	1.10
LTE Band 14	1.09
LTE Band 25/2	1.99
LTE Band 26/5	1.09
LTE Band 41	0.74
LTE Band 66/4	2.03
LTE Band 71	0.55
WI-FI (2.4GHz)	1.15
WI-FI (5GHz)	0.79
BT	0.16
SAR Limited(W/kg)	4.0
Maximum Simultaneous Transmission SAR (W/kg)	
Scenario	Extremity
Sum SAR	3.97
SPLSR	/
SPLSR Limited	0.1



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1 General Information

1.1 General Description of EUT

Product Phase:	production unit	
Device Type:	portable device	
Exposure Category:	uncontrolled environment / general population	
IMEI:	868757070017963; 868757070016486; 868757070020439	
Hardware Version:	S2_XX_XX_00_XX	
Software Version:	03_61_10_01010000	
Antenna Type:	Integrated antennas	
Device Operating Configurations:		
Modulation Mode:	LTE:QPSK,16QAM; WIFI:DSSS,OFDM; BT:GFSK, π/4DQPSK, 8DPSK; NFC:ASK	
Frequency Bands:	Band	Tx(MHz)
	LTE Band 2	1850 ~1910
	LTE Band 4	1710~1755
	LTE Band 7	2500~2570
	LTE Band 12	699~716
	LTE Band 13	777~787
	LTE Band 14	788~798
	LTE Band 17	704-716
	LTE Band 25	1850~1915
	LTE Band 26	814~849
	LTE Band 41	2496~2690
	LTE Band 66	1710~1780
	WIFI 2.4G	2412~2462
	WIFI 5G	5150~5250
		5250~5350
		5470~5725
		5725~5850
BT	2402~2480	
NFC	13.56	



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RF Cable:	☒ Provided by applicant ☐ Provided by the laboratory
Battery:	Battery1 Model: NL7626A(2600mAh) Manufactured: Dongguan Veken Battery Co.,Ltd. Battery2 Model: NL7626A(2600mAh) Manufactured: EVE Energy Co.,Ltd. Battery3 Model: NL7635A(3500mAh) Manufactured: Dongguan Veken Battery Co.,Ltd.
Note: *Since the above data and/or information is provided by the client relevant results or conclusions of this report are only made for these data and/or information , SGS is not responsible for the authenticity, integrity and results of the data and information and/or the validity of the conclusion.	

Remark:

	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Sample 6
	S2_33_00_0 0_XX (Standard Version)	S2_73_00_0 0_XX (LCD_2 Version)	S2_33_13_0 0_XX (SCAN Version)	S2_33_00_0 0_XX (Standard Version)	S2_73_00_0 0_XX (LCD_2 Version)	S2_33_13_0 0_XX (SCAN Version)
Battery Model	NL7626A	NL7626A	NL7635A	NL7635A	NL7635A	NL7626A
Battery Rated capacity	2600mAh	2600mAh	3500mAh	3500mAh	3500mAh	2600mAh
Battery nominal voltage	7.6V	7.6V	7.6V	7.6V	7.6V	7.6V
Battery manufact ured	Dongguan Veken Battery Co.,Ltd.	EVE Energy Co.,Ltd.	Dongguan Veken Battery Co.,Ltd.	Dongguan Veken Battery Co.,Ltd.	Dongguan Veken Battery Co.,Ltd.	EVE Energy Co.,Ltd.



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Standard Version as the main test;

LCD_2 Version adds scanning functionality based on EUT1. The report reevaluated the worst case for each frequency band.

SCAN Version adds an LCD screen based on EUT1. The report reevaluated the worst case for each frequency band.

1.1.1 DUT Antenna Locations (Back View)

The DUT Antenna Locations can be referred to Appendix D



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1.2 Test Specification

Identity	Document Title
FCC 47CFR §2.1093	Radiofrequency Radiation Exposure Evaluation: Portable Devices
ANSI/IEEE C95.1-1992	IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz – 300 GHz.
IEEE 1528-2013	Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques
KDB 941225 D05	SAR for LTE Devices v02r05
KDB 941225 D05A	LTE Rel.10 KDB Inquiry Sheet v01r02
KDB 248227 D01	SAR Guidance for IEEE 802.11 Wi-Fi SAR v02r02
KDB 447498 D04	Interim General RF Exposure Guidance v01
KDB 865664 D01	SAR Measurement 100 MHz to 6 GHz v01r04
KDB 865664 D02	RF Exposure Reporting v01r02
KDB 690783 D01	SAR Listings on Grants v01r03



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1.3 RF exposure limits

Human Exposure	Uncontrolled Environment General Population	Controlled Environment Occupational
Spatial Peak SAR* (Brain*Trunk)	1.60 mW/g	8.00 mW/g
Spatial Average SAR** (Whole Body)	0.08 mW/g	0.40 mW/g
Spatial Peak SAR*** (Hands/Feet/Ankle/Wrist)	4.00 mW/g	20.00 mW/g

Notes:

* The Spatial Peak value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time

** The Spatial Average value of the SAR averaged over the whole body.

*** The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure.

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation.)



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1.4 Test Location

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Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

1.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI (Member No. 1937)**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen EMC laboratory have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

- **FCC –Designation Number: CN1336**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1336. Test Firm Registration Number: 787754.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.



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2 Laboratory Environment

Temperature	Min. = 18°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	



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3 SAR Measurements System Configuraion

3.1 The SAR Measurement System

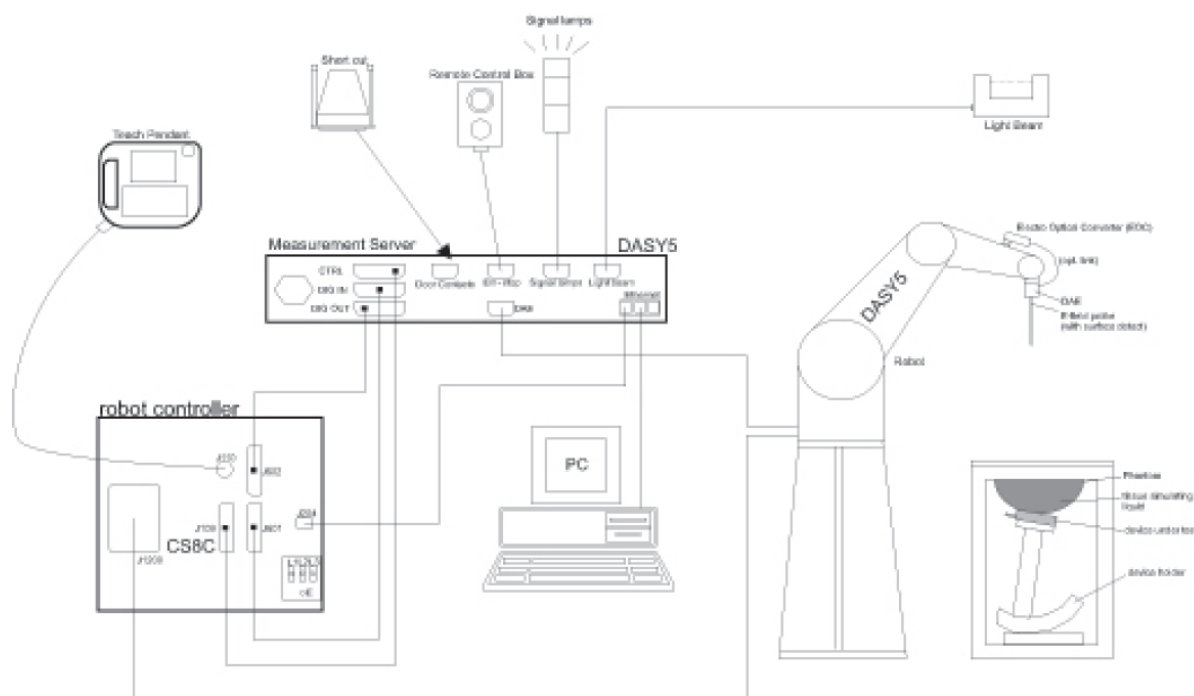
This SAR Measurement System uses a Computer-controlled 3-D stepper motor system (SPEAG DASY professional system). A E-field probe is used to determine the internal electric fields. The SAR can be obtained from the equation $SAR = \sigma (|E|^2) / \rho$ where σ and ρ are the conductivity and mass density of the tissue-Simulate.

The DASY system for performing compliance tests consists of the following items:
A standard high precision 6-axis robot (Stabile RX family) with controller, teach pendant and software. An arm extension for accommodation the data acquisition electronics (DAE).

A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.

A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.

The Electro-optical converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.



F-1. SAR Measurement System Configuration

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- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the (absolute) accuracy of the probe positioning.
- A computer operating Windows system.
- DASY software.
- Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.
- The SAM twin phantom enabling testing left-hand, right-hand and Body Worn usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- Validation dipole kits allowing to validating the proper functioning of the system.



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3.2 Isotropic E-field Probe EX3DV4

	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	ISO/IEC 17025 calibration service available.
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in TSL (rotation around probe axis) ± 0.5 dB in TSL (rotation normal to probe axis)
Dynamic Range	10 μ W/g to > 100 mW/g Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)
Dimensions	Overall length: 337 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure scenario (e.g., very strong gradient fields); the only probe that enables compliance testing for frequencies up to 6 GHz with precision of better 30%.
Compatibility	DASY52 SAR and higher, EASY4/MRI

3.3 Data Acquisition Electronics (DAE)

Model	DAE
Construction	Signal amplifier, multiplexer, A/D converter and control logic. Serial optical link for communication with DASY4/5 embedded system (fully remote controlled). Two step probe touch detector for mechanical surface detection and emergency robot stop.
Measurement Range	-100 to +300 mV (16 bit resolution and two range settings: 4mV,400mV)
Input Offset Voltage	< 5μV (with auto zero)
Input Bias Current	< 50 f A
Dimensions	60 x 60 x 68 mm



3.4 SAM Twin Phantom

Material	Vynlester, glass fiber reinforced (VE-GF)
Liquid Compatibility	Compatible with all SPEAG tissue simulating liquids (incl. DGBE type)
Shell Thickness	2 ± 0.2 mm (6 ± 0.2 mm at ear point)
Dimensions (incl. Wooden Support)	Length: 1000 mm Width: 500 mm Height: adjustable feet
Filling Volume	pprox.. 25 liters
Wooden Support	SPEAG standard phantom table



The shell corresponds to the specifications of the Specific Anthropomorphic Mannequin (SAM) phantom defined in IEEE 1528 and IEC 62209-1. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents evaporation of the liquid. Reference markings on the phantom allow the complete setup of all predefined phantom positions and measurement grids by teaching three points with the robot.

Twin SAM V5.0 has the same shell geometry and is manufactured from the same material as Twin SAM V4.0, but has reinforced top structure.

3.5 ELI Phantom

Material	Vinylester, glass fiber reinforced (VE-GF)	
Liquid Compatibility	Compatible with all SPEAG tissue simulating liquids (incl. DGBE type)	
Shell Thickness	2.0 ± 0.2 mm(bottom plate)	
Dimensions	Major axis: 600 mm Minor axis: 400 mm	
Filling Volume	pprox.. 30 liters	
Wooden Support	SPEAG standard phantom table	

Phantom for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI is fully compatible with the IEC 62209-2 standard and all known tissue simulating liquids. ELI has been optimized regarding its performance and can be integrated into our standard phantom tables. A cover prevents evaporation of the liquid. Reference markings on the phantom allow installation of the complete setup, including all predefined phantom positions and measurement grids, by teaching three points. The phantom is compatible with all SPEAG dosimetric probes and dipoles.

ELI V5.0 has the same shell geometry and is manufactured from the same material as ELI4 but has reinforced top structure.

3.6 Device Holder for Transmitters



F-2. Device Holder for Transmitters

- The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation centres for both scales are the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.
- The DASY device holder has been made out of low-loss POM material having the following dielectric parameters: relative permittivity $\epsilon=3$ and loss tangent $\delta=0.02$. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.

3.7 Measurement Procedure

3.7.1 Scanning procedure

Step 1: Power reference measurement

The “reference” and “drift” measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure.

Step 2: Area scan

The SAR distribution at the exposed side of the head was measured at a distance of 4mm from the inner surface of the shell. The area covered the entire dimension of the head and the horizontal grid spacing was 15mm*15mm or 12mm*12mm or 10mm*10mm. Based on the area scan data, the area of the maximum absorption was determined by spline interpolation.

Step 3: Zoom scan

Around this point, a volume of 32mm*32mm*30mm ($f \leq 2\text{GHz}$), 30mm*30mm*30mm (f for 2-3GHz) and 24mm*24mm*22mm (f for 5-6GHz) was assessed by measuring 5x5x7 points ($f \leq 2\text{GHz}$), 7x7x7 points (f for 2-3GHz) and 7x7x12 points (f for 5-6GHz). On this basis of this data set, the spatial peak SAR value was evaluated with the following procedure:

The data at the surface was extrapolated, since the centre of the dipoles is 2.0mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 1.2mm. (This can be variable. Refer to the probe specification). The extrapolation was based on a least square algorithm. A polynomial of the fourth order was calculated through the points in z-axes. This polynomial was then used to evaluate the points between the surface and the probe tip. The maximum interpolated value was searched with a straight-forward algorithm. Around this maximum the SAR values averaged over the spatial volumes (1g or 10g) were computed using the 3D-Spline interpolation algorithm. The volume was integrated with the trapezoidal algorithm. One thousand points were interpolated to calculate the average. All neighbouring volumes were evaluated until no neighboring volume with a higher average value was found.

The area and zoom scan resolutions specified in the table below must be applied to the SAR measurements. Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1-g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEEE Std. 1528-2013.

		$\leq 3 \text{ GHz}$	$> 3 \text{ GHz}$
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface		$5 \pm 1 \text{ mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location		$30^\circ \pm 1^\circ$	$20^\circ \pm 1^\circ$
Maximum area scan spatial resolution: $\Delta x_{\text{Area}}, \Delta y_{\text{Area}}$		$\leq 2 \text{ GHz}: \leq 15 \text{ mm}$ $2 - 3 \text{ GHz}: \leq 12 \text{ mm}$	$3 - 4 \text{ GHz}: \leq 12 \text{ mm}$ $4 - 6 \text{ GHz}: \leq 10 \text{ mm}$
		When the x or y dimension of the test device, in the measurement plane orientation, is smaller than the above, the measurement resolution must be $\leq$ the corresponding x or y dimension of the test device with at least one measurement point on the test device.	
Maximum zoom scan spatial resolution: $\Delta x_{\text{Zoom}}, \Delta y_{\text{Zoom}}$		$\leq 2 \text{ GHz}: \leq 8 \text{ mm}$ $2 - 3 \text{ GHz}: \leq 5 \text{ mm}^*$	$3 - 4 \text{ GHz}: \leq 5 \text{ mm}^*$ $4 - 6 \text{ GHz}: \leq 4 \text{ mm}^*$
Maximum zoom scan spatial resolution, normal to phantom surface	uniform grid: $\Delta z_{\text{Zoom}}(n)$	$\leq 5 \text{ mm}$	$3 - 4 \text{ GHz}: \leq 4 \text{ mm}$ $4 - 5 \text{ GHz}: \leq 3 \text{ mm}$ $5 - 6 \text{ GHz}: \leq 2 \text{ mm}$
	graded grid $\Delta z_{\text{Zoom}}(1)$: between 1 st two points closest to phantom surface	$\leq 4 \text{ mm}$	$3 - 4 \text{ GHz}: \leq 3 \text{ mm}$ $4 - 5 \text{ GHz}: \leq 2.5 \text{ mm}$ $5 - 6 \text{ GHz}: \leq 2 \text{ mm}$
	$\Delta z_{\text{Zoom}}(n>1)$: between subsequent points	$\leq 1.5 \cdot \Delta z_{\text{Zoom}}(n-1)$	
Minimum zoom scan volume	x, y, z	$\geq 30 \text{ mm}$	$3 - 4 \text{ GHz}: \geq 28 \text{ mm}$ $4 - 5 \text{ GHz}: \geq 25 \text{ mm}$ $5 - 6 \text{ GHz}: \geq 22 \text{ mm}$

Step 4: Power reference measurement (drift)

The Power Drift Measurement job measures the field at the same location as the most recent power reference measurement job within the same procedure, and with the same settings. The indicated drift is mainly the variation of the DUT's output power and should vary max. $\pm 5 \%$.

3.7.2 Data storage

The DASY software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension "DAE". The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated. The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [m W/g], [m W/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

3.7.3 Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, ai0, ai1, ai2
- Conversion factor	ConvFi	
- Diode compression point	Dcpi	
Device parameters:	- Frequency	f
- Crest factor	cf	
Media parameters:	- Conductivity	ε
- Density	ρ	

These parameters must be set correctly in the software. They can be found in the component documents, or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics.

If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot cf / dcp_i$$

With V_i = compensated signal of channel I (I = x, y, z)

U_i = input signal of channel I (I = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp I = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes:

$$E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$$



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H-field probes:

$$H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1}f + a_{i2}f^2) / f$$

With V_i = compensated signal of channel i ($i = x, y, z$)

Normi = sensor sensitivity of channel i ($i = x, y, z$)

[mV/(V/m)²] for E-field Probes

ConvF = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot}^2 \cdot \sigma) / (\epsilon \cdot 1000)$$

with SAR = local specific absorption rate in mW/g

E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [Siemens/m]

ϵ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

$$P_{pwe} = E_{tot}^2 / 3770 \text{ or } P_{pwe} = H_{tot}^2 \cdot 37.7$$

with P_{pwe} = equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m



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4 SAR measurement variability and uncertainty

4.1 SAR measurement variability

Per KDB 865664 D01 SAR measurement 100 MHz to 6 GHz v01r04, SAR measurement variability must be assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. The additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

- 1) Repeated measurement is not required when the original highest measured SAR is < 0.80 W/kg; steps 2) through 4) do not apply.
- 2) When the original highest measured SAR is ≥ 0.80 W/kg, repeat that measurement once.
- 3) Perform a second repeated measurement only if the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20 or when the original or repeated measurement is ≥ 1.45 W/kg ($\sim 10\%$ from the 1-g SAR limit).
- 4) Perform a third repeated measurement only if the original, first or second repeated measurement is ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20 .

The same procedures should be adapted for measurements according to extremity and occupational exposure limits by applying a factor of 2.5 for extremity exposure and a factor of 5 for occupational exposure to the corresponding SAR thresholds.

4.2 SAR measurement uncertainty

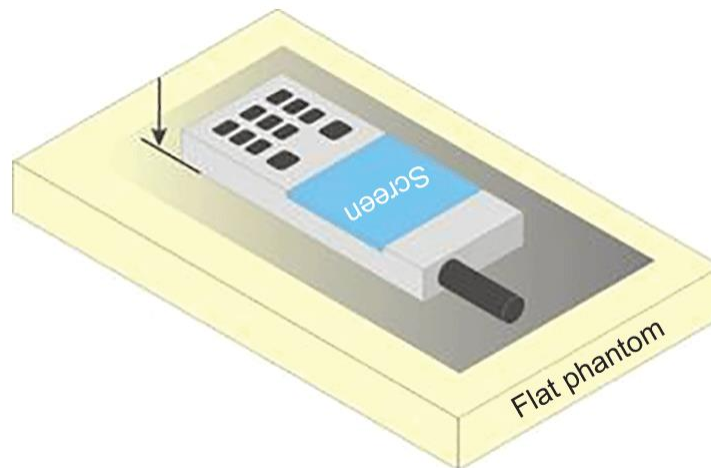
Per KDB865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is < 1.5 W/kg, the extensive SAR measurement uncertainty analysis described in IEEE Std 1528-2013 is not required in SAR reports submitted for equipment approval. The equivalent ratio (1.5/1.6) is applied to extremity and occupational exposure conditions.



5 Description of Test Position

5.1 Hand-held usage of the device, not at the head or torso

When SAR measurement is necessary for hand-held devices that do not transmit while at the head or torso, a flat phantom may be used. To assess this type of device, the device shall be placed directly against the flat phantom as shown in the below Figure, for the sides of the device that are in contact with the hand for the intended use.



a) Test position for hand-held devices, not used at the head or torso

6 SAR System Verificaion Procedure

6.1 Tissue Simulate Liquid

6.1.1 Recipes for Tissue Simulate Liquid

The bellowing tables give the recipes for tissue simulating liquids to be used in different frequency bands:

Ingredients (% by weight)	Frequency (MHz)				
	450	700-1000	1700-2000	2300-2500	2500-2700
Water	38.56	40.30	55.24	55.00	54.92
Salt (NaCl)	3.95	1.38	0.31	0.2	0.23
Sucrose	56.32	57.90	0	0	0
HEC	0.98	0.24	0	0	0
Bactericide	0.19	0.18	0	0	0
Tween	0	0	44.45	44.80	44.85
Salt: 99+% Pure Sodium Chloride Water: De-ionized, 16 MΩ+ resistivity Tween: Polyoxyethylene (20) sorbitan monolaurate Sucrose: 98+% Pure Sucrose HEC: Hydroxyethyl Cellulose					
HSL5GHz is composed of the following ingredients: (Manufactured by SPEAG) Water: 50-65% Mineral oil: 10-30% Emulsifiers: 8-25% Sodium salt: 0-1.5%					

Table 1 : Recipe of Tissue Simulate Liquid

6.1.2 Measurement for Tissue Simulate Liquid

The Conductivity (σ) and Permittivity (ϵ_r) are listed in Table 2. For the SAR measurement given in this report.

The temperature variation of the Tissue Simulate Liquids was $22 \pm 2^\circ\text{C}$.

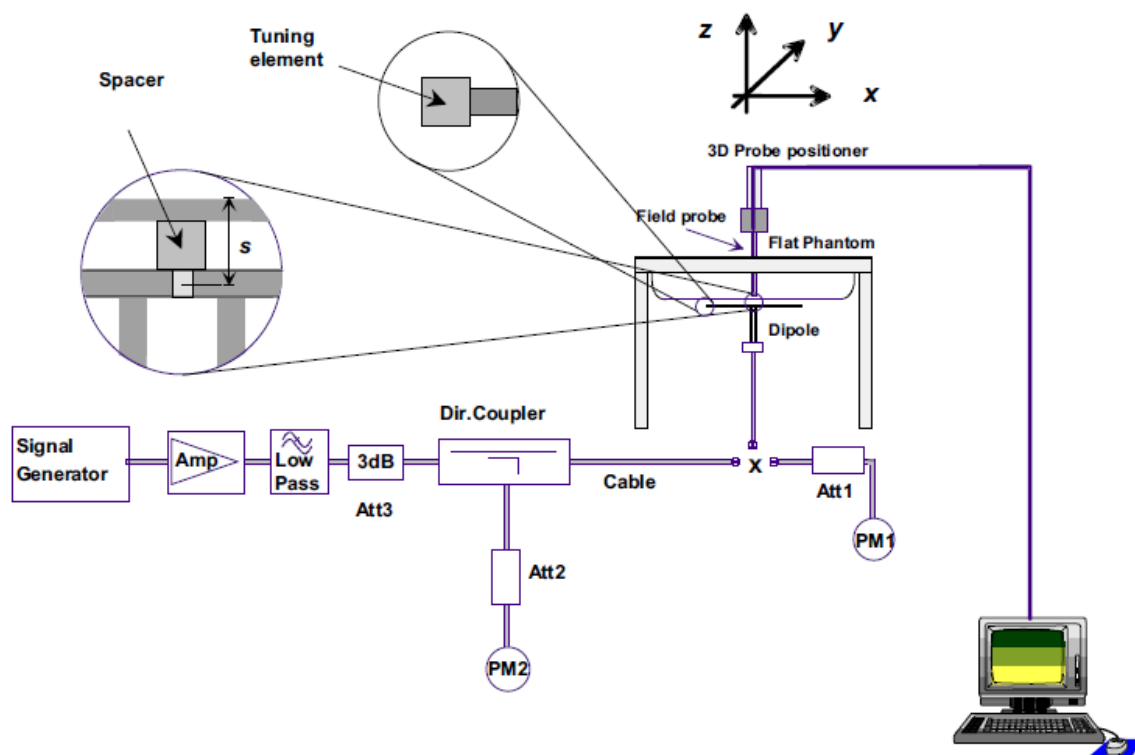
Tissue Type	Measured Frequency (MHz)	Measured Tissue		Target Tissue ($\pm 5\%$)		Deviation (Within $\pm 5\%$)		Liquid Temp. ($^\circ\text{C}$)	Test Date
		ϵ_r	$\sigma(\text{S/m})$	ϵ_r	$\sigma(\text{S/m})$	ϵ_r	$\sigma(\text{S/m})$		
750 Head	750	42.921	0.874	41.90	0.89	2.44%	-1.84%	22.3	2025/7/23
835 Head	835	42.429	0.924	41.50	0.90	2.24%	2.62%	22.6	2025/7/28
1750 Head	1750	40.548	1.384	40.10	1.37	1.12%	1.04%	22.2	2025/8/7
1900 Head	1900	40.458	1.414	40.00	1.40	1.15%	1.00%	22.3	2025/7/25
2450 Head	2450	39.774	1.808	39.20	1.80	1.46%	0.44%	22.5	2025/7/22
2600 Head	2600	39.261	1.982	39.00	1.96	0.67%	1.12%	22.1	2025/7/26
5250 Head	5250	36.679	4.729	35.90	4.71	2.17%	0.40%	22.4	2025/7/24
5600 Head	5600	35.811	5.113	35.50	5.07	0.88%	0.85%	22.4	2025/7/24
5750 Head	5750	35.630	5.306	35.40	5.22	0.65%	1.65%	22.4	2025/7/24

Table 2 : Measurement result of Tissue electric parameters



6.2 SAR System Check

The microwave circuit arrangement for system Check is sketched in F-12. The daily system accuracy verification occurs within the flat section of the SAM phantom. A SAR measurement was performed to see if the measured SAR was within $\pm 10\%$ from the target SAR values. The tests were conducted on the same days as the measurement of the EUT. The obtained results from the system accuracy verification are displayed in the following table (A power level of 250mW (below 3GHz) or 100mW (3-6GHz) was input to the dipole antenna). During the tests, the ambient temperature of the laboratory was in the range $22\pm 2^\circ\text{C}$, the relative humidity was in the range 60% and the liquid depth above the ear reference points was above $15\pm 0.5\text{ cm}$ in all the cases. It is seen that the system is operating within its specification, as the results are within acceptable tolerance of the reference values.



F-12.The microwave circuit arrangement used for SAR system Check

6.2.1 Justification for Extended SAR Dipole Calibrations

1) Instead of the typical annual calibration recommended by measurement standards, longer calibration intervals of up to three years may be considered when it is demonstrated that the SAR target, impedance and return loss of a dipole have remain stable according to the following requirements. Each measured dipole is expected to evaluate with the following criteria at least on annual interval in Appendix C.

- a) There is no physical damage on the dipole;
- b) System check with specific dipole is within 10% of calibrated value;
- c) Return-loss is within 20% of calibrated measurement;
- d) Impedance is within 5Ω from the previous measurement.

2) Network analyzer probe calibration against air, distilled water and a shorting block performed before measuring liquid parameters.



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6.2.2 Summary System Check Result(s)

Validation Kit	Measured SAR 250mW	Measured SAR 250mW	Measured SAR (normalized to 1W)	Measured SAR (normalized to 1W)	Target SAR (normalized to 1W)	Target SAR (normalized to 1W)	Deviation (Within ±10%)		Liquid Temp. (°C)	Test Date
	1g (W/kg)	10g (W/kg)	1g (W/kg)	10g (W/kg)	10-g(W/kg)	10-g(W/kg)	10-g(W/kg)	10-g(W/kg)		
D750V3_Head	2.16	1.41	8.64	5.64	8.42	5.49	2.61%	2.73%	22.3	2025/7/23
D835V2_Head	2.33	1.54	9.32	6.16	9.53	6.29	-2.20%	-2.07%	22.6	2025/7/28
D1750V2_Head	9.54	5.13	38.16	20.52	36.20	19.10	5.41%	7.43%	22.8	2025/8/7
D1900V2_Head	9.84	5.34	39.36	21.36	39.50	20.60	-0.35%	3.69%	22.3	2025/7/25
D2450V2_Head	13.60	6.25	54.40	25.00	52.20	24.30	4.21%	2.88%	22.5	2025/7/22
D2600V2_Head	14.00	6.27	56.00	25.08	55.30	24.70	1.27%	1.54%	22.1	2025/7/26
Validation Kit	Measured SAR 100mW	Measured SAR 100mW	Measured SAR (normalized to 1W)	Measured SAR (normalized to 1W)	Target SAR (normalized to 1W)	Target SAR (normalized to 1W)	Deviation (Within ±10%)		Liquid Temp. (°C)	Test Date
	1g (W/kg)	10g (W/kg)	1g (W/kg)	10g (W/kg)	10-g(W/kg)	10-g(W/kg)	10-g(W/kg)	10-g(W/kg)		
D5GHzV2_5.25G_Head	7.51	2.18	75.10	21.80	77.30	22.10	-2.85%	-1.36%	22.4	2025/7/24
D5GHzV2_5.6G_Head	8.49	2.43	84.90	24.30	81.30	23.10	4.43%	5.19%	22.4	2025/7/24
D5GHzV2_5.75G_Head	7.41	2.13	74.10	21.30	77.10	21.30	-3.89%	0.00%	22.4	2025/7/24

Table 3 : SAR System Check Result

6.2.3 Detailed System Check Results

Please see the Appendix A



7 Test Configuration

7.1 Operation Configurations

7.1.1 WIFI Test Configuration

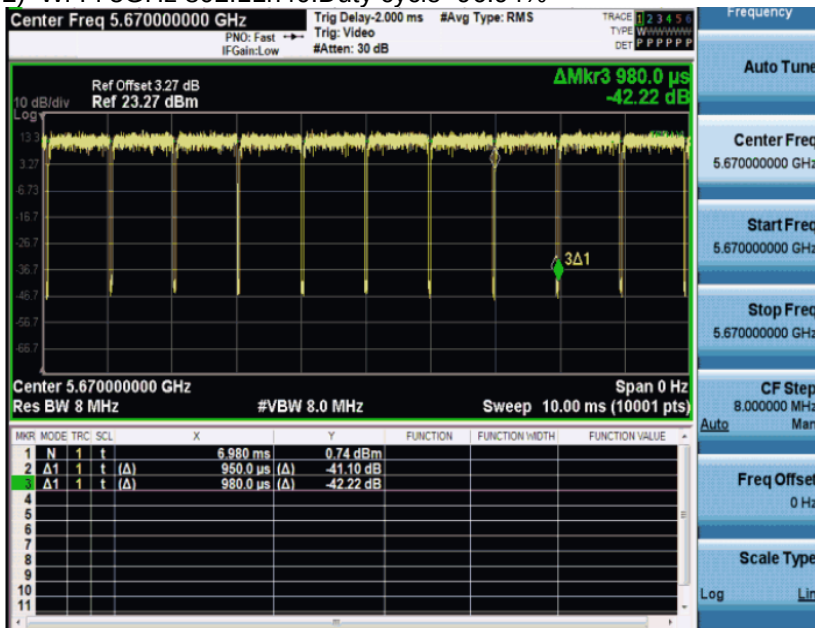
A Wi-Fi device must be configured to transmit continuously at the required data rate, channel bandwidth and signal modulation, using the highest transmission duty factor supported by the test mode tools for SAR measurement.

7.1.1.1 Duty cycle

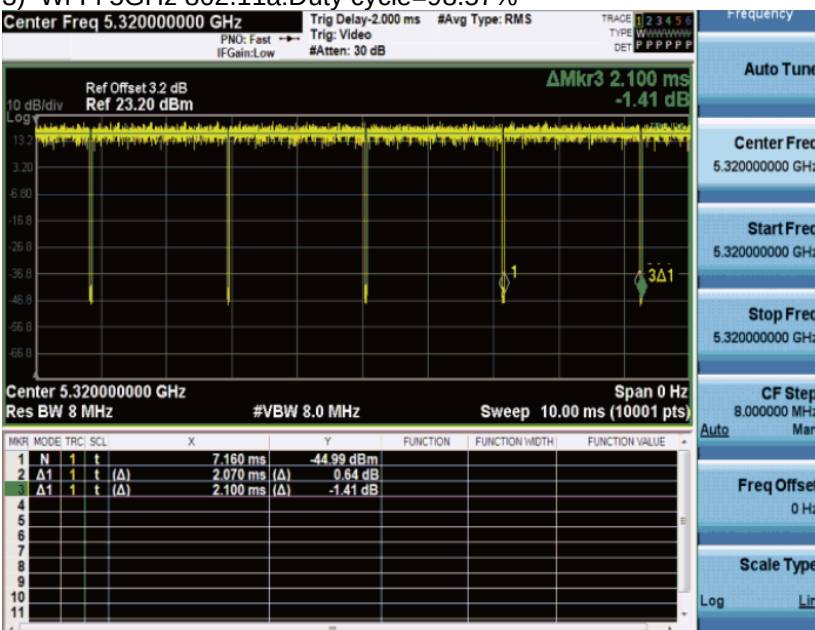
1) Wi-Fi 2.4GHz 802.11b:Duty cycle=98.57%



2) Wi-Fi 5GHz 802.11n40:Duty cycle=96.94%



3) Wi-Fi 5GHz 802.11a:Duty cycle=98.57%



7.1.1.2 Initial Test Position SAR Test Reduction Procedure

DSSS and OFDM configurations are considered separately according to the required SAR procedures. SAR is measured in the initial test position using the 802.11 transmission mode configuration required by the DSSS procedure or initial test configuration and subsequent test configuration(s) according to the OFDM procedures. The initial test position procedure is described in the following:

- 1) . When the reported SAR of the initial test position is ≤ 0.4 W/kg, further SAR measurement is not required for the other (remaining) test positions in that exposure configuration and 802.11 transmission mode combinations within the frequency band or aggregated band. SAR is also not required for that exposure configuration in the subsequent test configuration(s).
- 2) . When the reported SAR of the initial test position is > 0.4 W/kg, SAR is repeated for the 802.11 transmission mode configuration tested in the initial test position using subsequent highest extrapolated or estimated 1-g SAR conditions determined by area scans or next closest/smallest test separation distance and maximum RF coupling test positions based on manufacturer justification, on the highest maximum output power channel, until the reported SAR is ≤ 0.8 W/kg or all required test positions (left, right, touch, tilt or subsequent surfaces and edges) are tested.
- 3) . For all positions/configurations tested using the initial test position and subsequent test positions, when the reported SAR is > 0.8 W/kg, SAR is measured for these test positions/configurations on the subsequent next highest measured output power channel(s) until the reported SAR is ≤ 1.2 W/kg or all required channels are tested. a) Additional power measurements may be required for this step, which should be limited to those necessary for identifying the subsequent highest output power channels.

7.1.1.3 Subsequent Test Configuration Procedures

SAR measurement requirements for the remaining 802.11 transmission mode configurations that have not been tested in the initial test configuration are determined separately for each standalone and aggregated frequency band, in each exposure condition, according to the maximum output power specified for production units. The initial test position procedure is applied to next to the ear, UMPC mini-tablet and hotspot mode configurations. When the same maximum output power is specified for multiple transmission modes, additional power measurements may be required to determine if SAR measurements are required for subsequent highest output power channels in a subsequent test configuration. The subsequent test configuration and SAR measurement procedures are described in the following.

- 1) . When SAR test exclusion provisions of KDB Publication 447498 are applicable and SAR measurement is not required for the initial test configuration, SAR is also not required for the next highest maximum output power transmission mode subsequent test configuration(s) in that frequency band or aggregated band and exposure configuration.
- 2) . When the highest reported SAR for the initial test configuration (when applicable, include subsequent highest output channels), according to the initial test position or fixed exposure position requirements, is adjusted by the ratio of the subsequent test configuration to initial test configuration specified maximum output power and the adjusted SAR is ≤ 1.2 W/kg, SAR is not required for that subsequent test configuration.
- 3) . The number of channels in the initial test configuration and subsequent test configuration can be different due to differences in channel bandwidth. When SAR measurement is required for a subsequent test configuration and the channel bandwidth is smaller than that in the initial test configuration, all channels in the subsequent test configuration that overlap with the larger bandwidth channel tested in the initial test configuration should be used to determine the highest maximum output power channel. This step requires additional power measurement to identify the highest maximum output power channel in the subsequent test configuration to determine SAR test reduction.
 - a) SAR should first be measured for the channel with highest measured output power in the subsequent test configuration.
 - b) SAR for subsequent highest measured maximum output power channels in the subsequent test configuration is required only when the reported SAR of the preceding higher maximum output power channel(s) in the subsequent test configuration is > 1.2 W/kg or until all required channels are tested. i) For channels with the same measured maximum output power, SAR should be measured using the channel closest to the center frequency of the larger channel bandwidth channel in the initial test configuration.
- 4) . SAR measurements for the remaining highest specified maximum output power OFDM transmission mode configurations that have not been tested in the initial test configuration (highest maximum output) or subsequent test configuration(s) (subsequent next highest maximum output power) is determined by recursively applying the subsequent test configuration procedures in this section to the remaining configurations according to the following:
 - a) replace "subsequent test configuration" with "next subsequent test configuration" (i.e., subsequent next highest specified maximum output power configuration)
 - b) replace "initial test configuration" with "all tested higher output power configurations"

7.1.1.4 2.4 GHz WiFi SAR Procedures

Separate SAR procedures are applied to DSSS and OFDM configurations in the 2.4 GHz band to simplify DSSS test requirements. For 802.11b DSSS SAR measurements, DSSS SAR procedure applies to fixed exposure test position and initial test position procedure applies to multiple exposure test positions. When SAR measurement is required for an OFDM configuration, the initial test configuration, subsequent test configuration and initial test position procedures are applied. The SAR test exclusion requirements for 802.11g/n OFDM configurations are described in following.

• 802.11b DSSS SAR Test Requirements

SAR is measured for 2.4 GHz 802.11b DSSS using either a fixed test position or, when applicable, the initial test position procedure. SAR test reduction is determined according to the following:

- 1) . When the reported SAR of the highest measured maximum output power channel for the exposure configuration is ≤ 0.8 W/kg, no further SAR testing is required for 802.11b DSSS in that exposure configuration.
- 2) . When the reported SAR is > 0.8 W/kg, SAR is required for that exposure configuration using the next highest measured output power channel. When any reported SAR is > 1.2 W/kg, SAR is required for the third channel; i.e., all channels require testing.

• 2.4 GHz 802.11g/n OFDM SAR Test Exclusion Requirements

When SAR measurement is required for 2.4 GHz 802.11g/n OFDM configurations, the measurement and test reduction procedures for OFDM are applied (section 5.3, including sub-sections). SAR is not required for the following 2.4 GHz OFDM conditions.

- 1) . When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.
- 2) . When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2 W/kg.

• SAR Test Requirements for OFDM configurations

When SAR measurement is required for 802.11 g/n OFDM configurations, each standalone and frequency aggregated band is considered separately for SAR test reduction. In applying the initial test configuration and subsequent test configuration procedures, the 802.11 transmission configuration with the highest specified maximum output power and the channel within a test configuration with the highest measured maximum output power should be clearly distinguished to apply the procedures.

7.1.1.5 5 GHz WiFi SAR Procedures

• U-NII-1 and U-NII-2A Bands

For devices that operate in only one of the U-NII-1 and U-NII-2A bands, the normally required SAR procedures for OFDM configurations are applied. For devices that operate in both U-NII bands using the same transmitter and antenna(s), SAR test reduction is determined according to the following:

- 1) When the same maximum output power is specified for both bands, begin SAR measurement in U-NII-2A band by applying the OFDM SAR requirements. If the highest reported SAR for a test configuration is ≤ 1.2 W/kg, SAR is not required for U-NII-1 band for that configuration (802.11 mode and exposure condition); otherwise, both bands are tested independently for SAR.
- 2) When different maximum output power is specified for the bands, begin SAR measurement in the band with higher specified maximum output power. The highest reported SAR for the tested configuration is adjusted by the ratio of lower to higher specified maximum output power for the two bands. When the adjusted SAR is ≤ 1.2 W/kg, SAR is not required for the band with lower maximum output power in that test configuration; otherwise, both bands are tested independently for SAR.
- 3) The two U-NII bands may be aggregated to support a 160 MHz channel on channel number 50. Without additional testing, the maximum output power for this is limited to the lower of the maximum output power certified for the two bands. When SAR measurement is required for at least one of the bands and the highest reported SAR adjusted by the ratio of specified maximum output power of aggregated to standalone band is > 1.2 W/kg, SAR is required for the 160 MHz channel. This procedure does not apply to an aggregated band with maximum output higher than the standalone band(s); the aggregated band must be tested independently for SAR. SAR is not required when the 160 MHz channel is operating at a reduced maximum power and also qualifies for SAR test exclusion.

• U-NII-2C and U-NII-3 Bands

The frequency range covered by these bands is 380 MHz (5.47 – 5.85 GHz), which requires a minimum of at least two SAR probe calibration frequency points to support SAR measurements. when Terminal Doppler Weather Radar (TDWR) restriction applies, all channels that operate at 5.60 – 5.65 GHz must be included to apply the SAR test reduction and measurement procedures.

When the same transmitter and antenna(s) are used for U-NII-2C band and U-NII-3 band or 5.8 GHz band of §15.247, the bands may be aggregated to enable additional channels with 20, 40 or 80 MHz bandwidth to span across the band gap, as illustrated in Appendix B. The maximum output power for the additional band gap channels is limited to the lower of those certified for the bands. Unless band gap channels are permanently disabled, they must be considered for SAR testing. The frequency range covered by these bands is 380 MHz (5.47 – 5.85 GHz), which requires a minimum of at least two SAR probe calibration frequency points to support SAR measurements. To maintain SAR measurement accuracy and to facilitate test reduction, the channels in U-NII-2C band above 5.65 GHz may be grouped with the 5.8 GHz channels in U-NII-3 or §15.247 band to enable two SAR probe calibration frequency points to cover the bands, including the band gap channels. When band gap channels are supported and the bands are not aggregated for SAR testing, band gap channels must be considered independently in each band according to the normally required OFDM SAR measurement and probe calibration frequency points requirements.



OFDM Transmission Mode SAR Test Configuration and Channel Selection Requirements

The initial test configuration for 5 GHz OFDM transmission modes is determined by the 802.11 configuration with the highest maximum output power specified for production units, including tune-up tolerance, in each standalone and aggregated frequency band. SAR for the initial test configuration is measured using the highest maximum output power channel determined by the default power measurement procedures. When multiple configurations in a frequency band have the same specified maximum output power, the initial test configuration is determined according to the following steps applied sequentially.

- 1) The largest channel bandwidth configuration is selected among the multiple configurations with the same specified maximum output power.
- 2) If multiple configurations have the same specified maximum output power and largest channel bandwidth, the lowest order modulation among the largest channel bandwidth configurations is selected.
- 3) If multiple configurations have the same specified maximum output power, largest channel bandwidth and lowest order modulation, the lowest data rate configuration among these configurations is selected.
- 4) When multiple transmission modes (802.11a/g/n/ac) have the same specified maximum output power, largest channel bandwidth, lowest order modulation and lowest data rate, the lowest order 802.11 mode is selected; i.e., 802.11a is chosen over 802.11n then 802.11ac or 802.11g is chosen over 802.11n. After an initial test configuration is determined, if multiple test channels have the same measured maximum output power, the channel chosen for SAR measurement is determined according to the following. These channel selection procedures apply to both the initial test configuration and subsequent test configuration(s), with respect to the default power measurement procedures or additional power measurements required for further SAR test reduction. The same procedures also apply to subsequent highest output power channel(s) selection.
 - a) The channel closest to mid-band frequency is selected for SAR measurement.
 - b) For channels with equal separation from mid-band frequency; for example, high and low channels or two mid-band channels, the higher frequency (number) channel is selected for SAR measurement.

• SAR Test Requirements for OFDM configurations

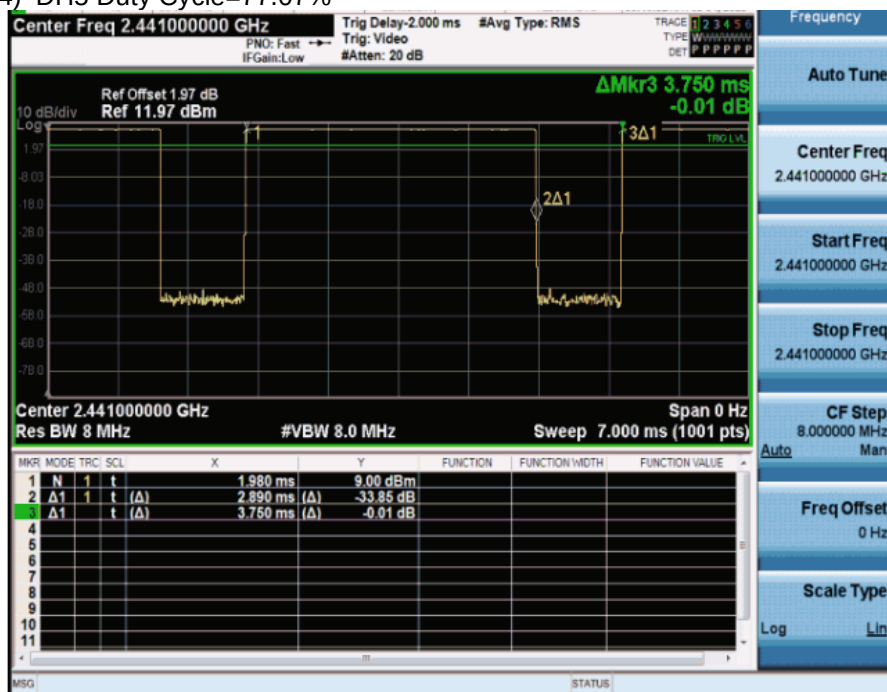
When SAR measurement is required for 802.11 a/n/ac OFDM configurations, each standalone and frequency aggregated band is considered separately for SAR test reduction. When the same transmitter and antenna(s) are used for U-NII-1 and U-NII-2A bands, additional SAR test reduction applies. When band gap channels between U-NII-2C band and 5.8 GHz U-NII-3 or §15.247 band are supported, the highest maximum output power transmission mode configuration and maximum output power channel across the bands must be used to determine SAR test reduction, according to the initial test configuration and subsequent test configuration requirements. In applying the initial test configuration and subsequent test configuration procedures, the 802.11 transmission configuration with the highest specified maximum output power and the channel within a test configuration with the highest measured maximum output power should be clearly distinguished to apply the procedures.



7.1.2 BT Test Configuration

For the Bluetooth SAR tests, a communication link is set up with the test mode software for BT mode test. Bluetooth USES frequency hopping technology to divide the transmitted data into packets and transmit the packets respectively through 79 designated Bluetooth channels, frequency hops at 1600 hops/second per the Bluetooth standard, the EUT is operated at the RF continuous emission mode.

4) DH5 Duty Cycle=77.07%



7.1.3 LTE Test Configuration

LTE modes were tested according to FCC KDB 941225 D05 publication. Please see notes after the tabulated SAR data for required test configurations. Establishing connections with base station simulators ensure a consistent means for testing SAR and are recommended for evaluating SAR [4]. The Radio Communication Analyzer was used for LTE output power measurements and SAR testing. Max power control was used so the UE transmits with maximum output power during SAR testing. SAR must be measured with the maximum TTI (transmit time interval) supported by the device in each LTE configuration.

TDD LTE test consideration

For Time-Division Duplex (TDD) systems, SAR must be tested using a fixed periodic duty factor according to the highest transmission duty factor implemented for the device and supported by the defined 3GPP LTE TDD configurations.

SAR was tested with the highest transmission duty factor (63.33%) using Uplink-downlink configuration 0 and Special subframe configuration 7.

LTE TDD Band support 3GPP TS 36.211 section 4.2 for Type 2 Frame Structure and Table 4.2-2 for uplink-downlink configurations and Table 4.2-1 for Special subframe configurations.

Frame structure type 2:

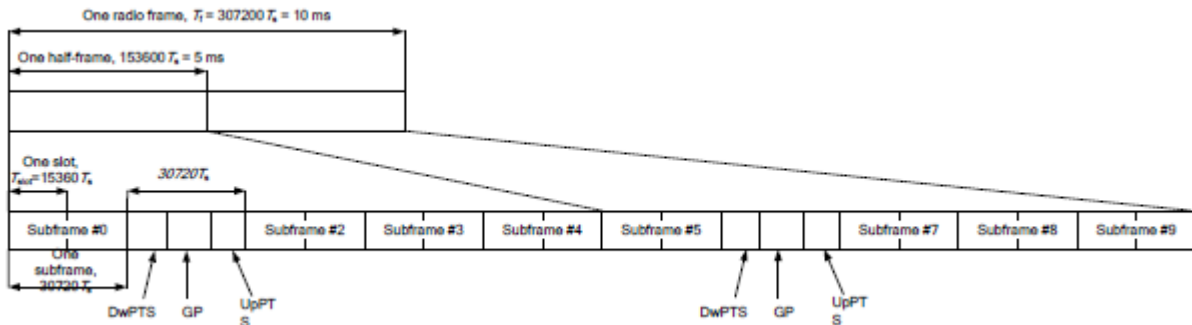


Table 4.2-1: Configuration of special subframe (lengths of DwPTS/GP/UpPTS).

Special subframe configuration	Normal cyclic prefix in downlink			Extended cyclic prefix in downlink		
	DwPTS	UpPTS		DwPTS	UpPTS	
		Normal cyclic prefix in uplink	Extended cyclic prefix in uplink		Normal cyclic prefix in uplink	Extended cyclic prefix in uplink
0	6592.Ts	2192.Ts	2560.Ts	7680.Ts	2192.Ts	2560.Ts
1	19760.Ts			20480.Ts		
2	21952.Ts			23040.Ts		
3	24144.Ts			25600.Ts		
4	26336.Ts	4384.Ts	5120.Ts	7680.Ts	4384.Ts	5120.Ts
5	6592.Ts			20480.Ts		
6	19760.Ts			23040.Ts		
7	21952.Ts			25600.Ts		
8	24144.Ts			-	-	-
9	13168.Ts			-	-	-

Table 4.2-2: Uplink-downlink configurations.

Uplink-downlink configuration	Downlink-to-Uplink Switch-point periodicity	Subframe number									
		0	1	2	3	4	5	6	7	8	9
0	5 ms	D	S	U	U	U	D	S	U	U	U
1	5 ms	D	S	U	U	D	D	S	U	U	D
2	5 ms	D	S	U	D	D	D	S	U	D	D
3	10 ms	D	S	U	U	U	D	D	D	D	D
4	10 ms	D	S	U	U	D	D	D	D	D	D
5	10 ms	D	S	U	D	D	D	D	D	D	D
6	5 ms	D	S	U	U	U	D	S	U	U	D

Calculated Duty Cycle=[Extended cyclic prefix in uplink x (Ts) x # of S + # of U]/10ms

Uplink-Downlink Configuration	Downlink-to-Uplink Switch-point Periodicity	Subframe Number										Calculated Duty Cycle (%)
		0	1	2	3	4	5	6	7	8	9	
0	5 ms	D	S	U	U	U	D	S	U	U	U	63.33
1	5 ms	D	S	U	U	D	D	S	U	U	D	43.33
2	5 ms	D	S	U	D	D	D	S	U	D	D	23.33
3	10 ms	D	S	U	U	U	D	D	D	D	D	31.67
4	10 ms	D	S	U	U	D	D	D	D	D	D	21.67
5	10 ms	D	S	U	D	D	D	D	D	D	D	11.67
6	5 ms	D	S	U	U	U	D	S	U	U	D	53.33

A) Spectrum Plots for RB Configurations

A properly configured base station simulator was used for SAR tests and power measurements. Therefore, spectrum plots for RB configurations were not required to be included in this report.

B) MPR

MPR is permanently implemented for this device by the manufacturer. The specific manufacturer target MPR is indicated alongside the SAR results. MPR is enabled for this device, according to 3GPP TS36.101 Section 6.2.3 – 6.2.5 under Table 6.2.3-1.

Modulation	Channel bandwidth/Transmission bandwidth						MPR (dB)
	1.4 MHz	3 MHz	5 MHz	10 MHz	15 MHz	20 MHz	
QPSK	≤ 5	≤ 4	≤ 8	≤ 12	≤ 16	≤ 18	0
QPSK	> 5	> 4	> 8	> 12	> 16	> 18	1
16QAM	≤ 5	≤ 4	≤ 8	≤ 12	≤ 16	≤ 18	1
16QAM	> 5	> 4	> 8	> 12	> 16	> 18	2
64QAM	≤ 5	≤ 4	≤ 8	≤ 12	≤ 16	≤ 18	2
64QAM	> 5	> 4	> 8	> 12	> 16	> 18	3
256QAM	≥ 1						5

C) A-MPR

A-MPR (Additional MPR) has been disabled for all SAR tests by setting NS=01 on the base station simulator.

D) Largest channel bandwidth standalone SAR test requirements

1) QPSK with 1 RB allocation

Start with the largest channel bandwidth and measure SAR for QPSK with 1 RB allocation, using the RB offset and required test channel combination with the highest maximum output power for RB offsets at the upper edge, middle and lower edge of each required test channel. When the reported SAR is ≤ 0.8 W/kg, testing of the remaining RB offset configurations and required test channels is not required for 1 RB allocation; otherwise, SAR is required for the remaining required test channels and only for the RB offset configuration with the highest output power for that channel. When the reported SAR of a required test channel is > 1.45 W/kg, SAR is required for all three RB offset configurations for that required test channel.

2) QPSK with 50% RB allocation

The procedures required for 1 RB allocation in 1) are applied to measure the SAR for QPSK with 50% RB allocation.

3) QPSK with 100% RB allocation

For QPSK with 100% RB allocation, SAR is not required when the highest maximum output power for 100 % RB allocation is less than the highest maximum output power in 50% and 1 RB allocations and the highest reported SAR for 1 RB and 50% RB allocation in 1) and 2) are ≤ 0.8 W/kg. Otherwise, SAR is measured for the highest output power channel and if the reported SAR is > 1.45 W/kg, the remaining required test channels must also be tested.

4) Higher order modulations

For each modulation besides QPSK; e.g., 16-QAM, 64-QAM, apply the QPSK procedures in above sections to determine the QAM configurations that may need SAR measurement. For each configuration identified as required for testing, SAR is required only when the highest maximum output power for the configuration in the higher order modulation is $> \frac{1}{2}$ dB higher than the same configuration in QPSK or when the reported SAR for the QPSK configuration is > 1.45 W/kg.

E) Other channel bandwidth standalone SAR test requirements

For the other channel bandwidths used by the device in a frequency band, apply all the procedures required for the largest channel bandwidth in section A) to determine the channels and RB configurations that need SAR testing and only measure SAR when the highest maximum output power of a configuration requiring testing in the smaller channel bandwidth is $> \frac{1}{2}$ dB higher than the equivalent channel configurations in the largest channel bandwidth configuration or the reported SAR of a configuration for the largest channel bandwidth is > 1.45 W/kg.



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8 Test Result

8.1 Measurement of RF Conducted Power

The detailed conducted power can be referred to Appendix E.



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8.2 Measurement of SAR Data

Note:

- 1) The maximum Scaled SAR value is marked in bold. Graph results refer to Appendix B.
- 2) For LTE bands that do not support at least three non-overlapping channels in certain channel bandwidths, test the available non-overlapping channels instead. When a device supports overlapping channel assignment in a channel bandwidth configuration, the middle channel of the group of overlapping channels should be selected for testing; therefore, the requirement for H, M, and L channels may not fully apply.
- 3) Per KDB447498 D04, testing of other required channels within the operating mode of a frequency band is not required when the reported 1-g or 10-g SAR for the mid-band or highest output power channel is:
 - $\leq 0.8 \text{ W/kg}$ for 1-g or 2.0 W/kg for 10-g respectively, when the transmission band is $\leq 100 \text{ MHz}$.
 - $\leq 0.6 \text{ W/kg}$ or 1.5 W/kg , for 1-g or 10-g respectively, when the transmission band is between 100 MHz and 200 MHz .
 - $\leq 0.4 \text{ W/kg}$ or 1.0 W/kg , for 1-g or 10-g respectively, when the transmission band is $\geq 200 \text{ MHz}$.

WiFi 2.4G:

- 1) When the highest reported SAR for the initial test configuration is adjusted by the ratio of the subsequent test configuration to initial test configuration specified maximum output power and the adjusted SAR is $\leq 1.2 \text{ W/kg}$, SAR test for the other 802.11 modes are not required.

WiFi 5G:

- 1) When the same maximum output power is specified for both bands, begin SAR measurement in U-NII-2A band by applying the OFDM SAR requirements. As the highest reported SAR for a test configuration is $\leq 1.2 \text{ W/kg}$, SAR is not required for U-NII-1 band for that configuration.
- 2) For Wi-Fi 5G, U-NII-2A (5250-5350 MHz) and U-NII-2C (5470-5725 MHz) bands does not support hotspot function.

When the highest reported SAR for the initial test configuration is adjusted by the ratio of the subsequent test configuration to initial test configuration specified maximum output power and the adjusted SAR is $\leq 1.2 \text{ W/kg}$, SAR test for the other 802.11 modes are not required.

8.2.1 SAR Result of LTE Band 7

LTE Band 7 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	20	QPSK 1_50	21100/2535	1:1	0.122	0.058	-0.04	23.92	25.00	1.282	0.074	22.1
Back side	20	QPSK 1_50	21100/2535	1:1	1.640	0.758	-0.08	23.92	25.00	1.282	0.972	22.1
Left side	20	QPSK 1_50	21100/2535	1:1	0.087	0.047	-0.05	23.92	25.00	1.282	0.060	22.1
Right side	20	QPSK 1_50	21100/2535	1:1	2.660	1.160	0.19	23.92	25.00	1.282	1.488	22.1
Right side-sample 2	20	QPSK 1_50	21100/2535	1:1	2.530	1.100	0.03	23.92	25.00	1.282	1.411	22.1
Right side-sample 3	20	QPSK 1_50	21100/2535	1:1	2.110	0.909	0.08	23.92	25.00	1.282	1.166	22.1
Top side	20	QPSK 1_50	21100/2535	1:1	0.093	0.052	0.15	23.92	25.00	1.282	0.067	22.1
Bottom side	20	QPSK 1_50	21100/2535	1:1	0.092	0.050	-0.12	23.92	25.00	1.282	0.064	22.1
Right side-sample 4	20	QPSK 1_50	21100/2535	1:1	2.620	1.140	0.04	23.92	25.00	1.282	1.462	22.1
Right side-sample 5	20	QPSK 1_50	21100/2535	1:1	2.600	1.120	0.04	23.92	25.00	1.282	1.436	22.1
Right side-sample 6	20	QPSK 1_50	21100/2535	1:1	2.510	1.050	-0.03	23.92	25.00	1.282	1.346	22.1
Extremity Test data (Separate 0mm 50%RB)												
Front side	20	QPSK 50_25	20850/2510	1:1	0.114	0.052	-0.14	23.87	24.00	1.030	0.054	22.1
Back side	20	QPSK 50_25	20850/2510	1:1	1.240	0.607	-0.07	23.87	24.00	1.030	0.625	22.1
Left side	20	QPSK 50_25	20850/2510	1:1	0.072	0.038	-0.05	23.87	24.00	1.030	0.039	22.1
Right side	20	QPSK 50_25	20850/2510	1:1	2.400	1.100	0.12	23.87	24.00	1.030	1.133	22.1
Top side	20	QPSK 50_25	20850/2510	1:1	0.070	0.041	0.06	23.87	24.00	1.030	0.042	22.1
Bottom side	20	QPSK 50_25	20850/2510	1:1	0.044	0.025	-0.11	23.87	24.00	1.030	0.026	22.1

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8.2.2 SAR Result of LTE Band 12

LTE Band 12 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	10	QPSK 1_25	23095/707.5	1:1	0.143	0.083	-0.06	24.31	25.00	1.172	0.097	22.3
Back side	10	QPSK 1_25	23095/707.5	1:1	0.997	0.451	-0.11	24.31	25.00	1.172	0.529	22.3
Left side	10	QPSK 1_25	23095/707.5	1:1	0.160	0.106	-0.06	24.31	25.00	1.172	0.124	22.3
Right side	10	QPSK 1_25	23095/707.5	1:1	1.130	0.670	0.10	24.31	25.00	1.172	0.785	22.3
Right side-sample 2	10	QPSK 1_25	23095/707.5	1:1	1.090	0.638	0.07	24.31	25.00	1.172	0.748	22.3
Right side-sample 3	10	QPSK 1_25	23095/707.5	1:1	1.040	0.550	0.01	24.31	25.00	1.172	0.645	22.3
Top side	10	QPSK 1_25	23095/707.5	1:1	0.088	0.058	0.07	24.31	25.00	1.172	0.068	22.3
Bottom side	10	QPSK 1_25	23095/707.5	1:1	0.027	0.014	0.03	24.31	25.00	1.172	0.016	22.3
Right side-sample 4	10	QPSK 1_25	23095/707.5	1:1	1.120	0.666	-0.04	24.31	25.00	1.172	0.781	22.3
Right side-sample 5	10	QPSK 1_25	23095/707.5	1:1	1.100	0.652	0.15	24.31	25.00	1.172	0.764	22.3
Right side-sample 6	10	QPSK 1_25	23095/707.5	1:1	1.050	0.650	-0.04	24.31	25.00	1.172	0.762	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	10	QPSK 25_13	23095/707.5	1:1	0.100	0.068	-0.07	23.38	24.00	1.153	0.078	22.3
Back side	10	QPSK 25_13	23095/707.5	1:1	0.682	0.333	-0.08	23.38	24.00	1.153	0.384	22.3
Left side	10	QPSK 25_13	23095/707.5	1:1	0.128	0.086	0.13	23.38	24.00	1.153	0.099	22.3
Right side	10	QPSK 25_13	23095/707.5	1:1	0.924	0.547	0.12	23.38	24.00	1.153	0.631	22.3
Top side	10	QPSK 25_13	23095/707.5	1:1	0.070	0.046	0.02	23.38	24.00	1.153	0.053	22.3
Bottom side	10	QPSK 25_13	23095/707.5	1:1	0.023	0.012	0.00	23.38	24.00	1.153	0.014	22.3



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8.2.3 SAR Result of LTE Band 13

LTE Band 13 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	10	QPSK 1_0	23230/782	1:1	0.248	0.168	-0.11	23.91	25.00	1.285	0.216	22.3
Back side	10	QPSK 1_0	23230/782	1:1	0.970	0.430	0.15	23.91	25.00	1.285	0.553	22.3
Left side	10	QPSK 1_0	23230/782	1:1	0.127	0.080	0.14	23.91	25.00	1.285	0.103	22.3
Right side	10	QPSK 1_0	23230/782	1:1	1.430	0.854	0.09	23.91	25.00	1.285	1.098	22.3
Right side-sample 2	10	QPSK 1_0	23230/782	1:1	1.050	0.593	0.05	23.91	25.00	1.285	0.762	22.3
Right side-sample 3	10	QPSK 1_0	23230/782	1:1	1.240	0.678	0.07	23.91	25.00	1.285	0.871	22.3
Top side	10	QPSK 1_0	23230/782	1:1	0.131	0.093	-0.04	23.91	25.00	1.285	0.120	22.3
Bottom side	10	QPSK 1_0	23230/782	1:1	0.030	0.017	0.08	23.91	25.00	1.285	0.022	22.3
Right side-sample 4	10	QPSK 1_0	23230/782	1:1	1.200	0.648	-0.11	23.91	25.00	1.285	0.833	22.3
Right side-sample 5	10	QPSK 1_0	23230/782	1:1	1.180	0.624	-0.04	23.91	25.00	1.285	0.802	22.3
Right side-sample 6	10	QPSK 1_0	23230/782	1:1	1.220	0.667	-0.02	23.91	25.00	1.285	0.857	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	10	QPSK 25_0	23230/782	1:1	0.211	0.141	-0.11	22.92	24.00	1.282	0.181	22.3
Back side	10	QPSK 25_0	23230/782	1:1	0.717	0.349	-0.03	22.92	24.00	1.282	0.448	22.3
Left side	10	QPSK 25_0	23230/782	1:1	0.097	0.061	0.05	22.92	24.00	1.282	0.078	22.3
Right side	10	QPSK 25_0	23230/782	1:1	1.140	0.691	0.00	22.92	24.00	1.282	0.886	22.3
Top side	10	QPSK 25_0	23230/782	1:1	0.103	0.076	0.07	22.92	24.00	1.282	0.097	22.3
Bottom side	10	QPSK 25_0	23230/782	1:1	0.026	0.015	-0.13	22.92	24.00	1.282	0.019	22.3



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8.2.4 SAR Result of LTE Band 14

LTE Band 14 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	10	QPSK 1_25	23330/793	1:1	0.272	0.176	0.10	23.87	25.00	1.297	0.228	22.3
Back side	10	QPSK 1_25	23330/793	1:1	0.875	0.404	0.11	23.87	25.00	1.297	0.524	22.3
Left side	10	QPSK 1_25	23330/793	1:1	0.106	0.066	-0.13	23.87	25.00	1.297	0.086	22.3
Right side	10	QPSK 1_25	23330/793	1:1	1.400	0.837	0.19	23.87	25.00	1.297	1.086	22.3
Right side-sample 2	10	QPSK 1_25	23330/793	1:1	1.190	0.644	0.11	23.87	25.00	1.297	0.835	22.3
Right side-sample 3	10	QPSK 1_25	23330/793	1:1	1.220	0.678	0.05	23.87	25.00	1.297	0.879	22.3
Top side	10	QPSK 1_25	23330/793	1:1	0.125	0.091	0.08	23.87	25.00	1.297	0.118	22.3
Bottom side	10	QPSK 1_25	23330/793	1:1	0.036	0.022	-0.10	23.87	25.00	1.297	0.029	22.3
Right side-sample 4	10	QPSK 1_25	23330/793	1:1	1.210	0.656	0.05	23.87	25.00	1.297	0.851	22.3
Right side-sample 5	10	QPSK 1_25	23330/793	1:1	1.170	0.637	0.12	23.87	25.00	1.297	0.826	22.3
Right side-sample 6	10	QPSK 1_25	23330/793	1:1	1.230	0.662	0.14	23.87	25.00	1.297	0.859	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	10	QPSK 25_13	23330/793	1:1	0.221	0.144	-0.01	22.82	24.00	1.312	0.189	22.3
Back side	10	QPSK 25_13	23330/793	1:1	0.590	0.298	-0.05	22.82	24.00	1.312	0.391	22.3
Left side	10	QPSK 25_13	23330/793	1:1	0.083	0.051	0.11	22.82	24.00	1.312	0.067	22.3
Right side	10	QPSK 25_13	23330/793	1:1	1.130	0.666	-0.08	22.82	24.00	1.312	0.874	22.3
Top side	10	QPSK 25_13	23330/793	1:1	0.106	0.077	0.13	22.82	24.00	1.312	0.101	22.3
Bottom side	10	QPSK 25_13	23330/793	1:1	0.033	0.019	-0.07	22.82	24.00	1.312	0.025	22.3



8.2.5 SAR Result of LTE Band 25

LTE Band 25 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	20	QPSK 1_50	26140/1860	1:1	0.107	0.058	0.13	24.51	25.00	1.119	0.065	22.3
Back side	20	QPSK 1_50	26140/1860	1:1	1.900	0.955	0.14	24.51	25.00	1.119	1.069	22.3
Left side	20	QPSK 1_50	26140/1860	1:1	0.304	0.151	0.04	24.51	25.00	1.119	0.169	22.3
Right side	20	QPSK 1_50	26140/1860	1:1	3.390	1.780	0.12	24.51	25.00	1.119	1.993	22.3
Right side-sample 2	20	QPSK 1_50	26140/1860	1:1	3.540	1.740	0.06	24.51	25.00	1.119	1.948	22.3
Right side-sample 3	20	QPSK 1_50	26140/1860	1:1	2.750	1.370	0.04	24.51	25.00	1.119	1.534	22.3
Top side	20	QPSK 1_50	26140/1860	1:1	0.055	0.035	0.12	24.51	25.00	1.119	0.039	22.3
Bottom side	20	QPSK 1_50	26140/1860	1:1	0.161	0.090	0.00	24.51	25.00	1.119	0.101	22.3
Right side-sample 4	20	QPSK 1_50	26140/1860	1:1	3.320	1.750	-0.04	24.51	25.00	1.119	1.959	22.3
Right side-sample 5	20	QPSK 1_50	26140/1860	1:1	3.360	1.770	-0.01	24.51	25.00	1.119	1.981	22.3
Right side-sample 6	20	QPSK 1_50	26140/1860	1:1	3.280	1.720	-0.03	24.51	25.00	1.119	1.925	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	20	QPSK 50_25	26590/1905	1:1	0.080	0.043	-0.13	23.48	24.00	1.127	0.048	22.3
Back side	20	QPSK 50_25	26590/1905	1:1	1.220	0.665	0.06	23.48	24.00	1.127	0.750	22.3
Left side	20	QPSK 50_25	26590/1905	1:1	0.190	0.105	0.14	23.48	24.00	1.127	0.118	22.3
Right side	20	QPSK 50_25	26590/1905	1:1	2.410	1.260	-0.04	23.48	24.00	1.127	1.420	22.3
Top side	20	QPSK 50_25	26590/1905	1:1	0.042	0.029	-0.05	23.48	24.00	1.127	0.033	22.3
Bottom side	20	QPSK 50_25	26590/1905	1:1	0.106	0.064	-0.04	23.48	24.00	1.127	0.072	22.3

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8.2.6 SAR Result of LTE Band 26

LTE Band 26 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	15	QPSK 1_0	26965/841.5	1:1	0.202	0.137	-0.10	24.21	25.00	1.199	0.164	22.6
Back side	15	QPSK 1_0	26965/841.5	1:1	0.896	0.412	0.04	24.21	25.00	1.199	0.494	22.6
Left side	15	QPSK 1_0	26965/841.5	1:1	0.091	0.055	-0.13	24.21	25.00	1.199	0.066	22.6
Right side	15	QPSK 1_0	26965/841.5	1:1	1.520	0.906	-0.02	24.21	25.00	1.199	1.087	22.6
Right side-sample 2	15	QPSK 1_0	26965/841.5	1:1	1.270	0.706	-0.06	24.21	25.00	1.199	0.847	22.6
Right side-sample 3	15	QPSK 1_0	26965/841.5	1:1	1.450	0.767	0.01	24.21	25.00	1.199	0.920	22.6
Top side	15	QPSK 1_0	26965/841.5	1:1	0.333	0.239	-0.11	24.21	25.00	1.199	0.287	22.6
Bottom side	15	QPSK 1_0	26965/841.5	1:1	0.049	0.036	-0.15	24.21	25.00	1.199	0.043	22.6
Right side-sample 4	15	QPSK 1_0	26965/841.5	1:1	1.440	0.766	-0.13	24.21	25.00	1.199	0.919	22.6
Right side-sample 5	15	QPSK 1_0	26965/841.5	1:1	1.390	0.731	-0.04	24.21	25.00	1.199	0.877	22.6
Right side-sample 6	15	QPSK 1_0	26965/841.5	1:1	1.500	0.783	-0.07	24.21	25.00	1.199	0.939	22.6
Extremity Test data (Separate 0mm 50%RB)												
Front side	15	QPSK 36_0	26965/841.5	1:1	0.163	0.112	-0.15	23.76	24.00	1.057	0.118	22.6
Back side	15	QPSK 36_0	26965/841.5	1:1	0.581	0.324	0.09	23.76	24.00	1.057	0.342	22.6
Left side	15	QPSK 36_0	26965/841.5	1:1	0.074	0.044	0.12	23.76	24.00	1.057	0.046	22.6
Right side	15	QPSK 36_0	26965/841.5	1:1	1.190	0.692	0.15	23.76	24.00	1.057	0.731	22.6
Top side	15	QPSK 36_0	26965/841.5	1:1	0.207	0.149	-0.06	23.76	24.00	1.057	0.157	22.6
Bottom side	15	QPSK 36_0	26965/841.5	1:1	0.040	0.028	-0.01	23.76	24.00	1.057	0.030	22.6



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8.2.7 SAR Result of LTE Band 41

LTE Band 41 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	20	QPSK 1_50	41490/2680	1:1.58	0.085	0.042	-0.11	23.46	24.00	1.132	0.048	22.1
Back side	20	QPSK 1_50	41490/2680	1:1.58	0.923	0.449	-0.06	23.46	24.00	1.132	0.508	22.1
Left side	20	QPSK 1_50	41490/2680	1:1.58	0.059	0.030	-0.10	23.46	24.00	1.132	0.034	22.1
Right side	20	QPSK 1_50	41490/2680	1:1.58	1.550	0.656	-0.08	23.46	24.00	1.132	0.743	22.1
Right side-sample 2	20	QPSK 1_50	41490/2680	1:1.58	1.490	0.647	-0.03	23.46	24.00	1.132	0.733	22.1
Right side-sample 3	20	QPSK 1_50	41490/2680	1:1.58	1.440	0.630	0.07	23.46	24.00	1.132	0.713	22.1
Top side	20	QPSK 1_50	41490/2680	1:1.58	0.072	0.039	0.14	23.46	24.00	1.132	0.044	22.1
Bottom side	20	QPSK 1_50	41490/2680	1:1.58	0.043	0.021	0.11	23.46	24.00	1.132	0.024	22.1
Right side-sample 4	20	QPSK 1_50	41490/2680	1:1.58	1.540	0.652	0.09	23.46	24.00	1.132	0.738	22.1
Right side-sample 5	20	QPSK 1_50	41490/2680	1:1.58	1.450	0.641	-0.08	23.46	24.00	1.132	0.726	22.1
Right side-sample 6	20	QPSK 1_50	41490/2680	1:1.58	1.500	0.648	0.07	23.46	24.00	1.132	0.734	22.1
Extremity Test data (Separate 0mm 50%RB)												
Front side	20	QPSK 50_25	41490/2680	1:1.58	0.073	0.033	0.00	22.68	23.00	1.076	0.036	22.1
Back side	20	QPSK 50_25	41490/2680	1:1.58	0.752	0.347	-0.15	22.68	23.00	1.076	0.374	22.1
Left side	20	QPSK 50_25	41490/2680	1:1.58	0.046	0.024	-0.06	22.68	23.00	1.076	0.026	22.1
Right side	20	QPSK 50_25	41490/2680	1:1.58	1.160	0.493	0.07	22.68	23.00	1.076	0.531	22.1
Top side	20	QPSK 50_25	41490/2680	1:1.58	0.065	0.035	-0.04	22.68	23.00	1.076	0.038	22.1
Bottom side	20	QPSK 50_25	41490/2680	1:1.58	0.040	0.019	0.05	22.68	23.00	1.076	0.020	22.1

8.2.8 SAR Result of LTE Band 66

LTE Band 66 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	20	QPSK 1_50	132322/1745	1:1	0.136	0.079	0.10	21.37	22.50	1.297	0.102	22.3
Back side	20	QPSK 1_50	132322/1745	1:1	0.843	0.426	-0.02	21.37	22.50	1.297	0.553	22.3
Left side	20	QPSK 1_50	132322/1745	1:1	0.190	0.101	0.15	21.37	22.50	1.297	0.131	22.3
Right side	20	QPSK 1_50	132322/1745	1:1	3.080	1.550	-0.08	21.37	22.50	1.297	2.011	22.3
Top side	20	QPSK 1_50	132322/1745	1:1	0.057	0.032	0.06	21.37	22.50	1.297	0.042	22.3
Bottom side	20	QPSK 1_50	132322/1745	1:1	0.110	0.066	0.08	21.37	22.50	1.297	0.086	22.3
Right side	20	QPSK 1_0	132072/1720	1:1	2.680	1.350	-0.01	21.35	22.50	1.303	1.759	22.3
Right side	20	QPSK 1_50	132572/1770	1:1	2.790	1.460	0.05	21.06	22.50	1.393	2.034	22.3
Right side-sample 2	20	QPSK 1_50	132572/1770	1:1	2.800	1.400	0.08	21.06	22.50	1.393	1.950	22.3
Right side-sample 3	20	QPSK 1_50	132572/1770	1:1	3.000	1.440	0.06	21.06	22.50	1.393	2.006	22.3
Right side-sample 4	20	QPSK 1_50	132572/1770	1:1	2.720	1.420	-0.03	21.06	22.50	1.393	1.978	22.3
Right side-sample 5	20	QPSK 1_50	132572/1770	1:1	2.780	1.450	-0.05	21.06	22.50	1.393	2.020	22.3
Right side-sample 6	20	QPSK 1_50	132572/1770	1:1	2.740	1.440	-0.02	21.06	22.50	1.393	2.006	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	20	QPSK 50_25	132322/1745	1:1	0.107	0.061	-0.13	20.82	21.50	1.169	0.071	22.3
Back side	20	QPSK 50_25	132322/1745	1:1	0.649	0.328	-0.06	20.82	21.50	1.169	0.384	22.3
Left side	20	QPSK 50_25	132322/1745	1:1	0.147	0.079	0.18	20.82	21.50	1.169	0.092	22.3
Right side	20	QPSK 50_25	132322/1745	1:1	2.510	1.220	0.03	20.82	21.50	1.169	1.427	22.3
Top side	20	QPSK 50_25	132322/1745	1:1	0.044	0.023	0.15	20.82	21.50	1.169	0.027	22.3
Bottom side	20	QPSK 50_25	132322/1745	1:1	0.084	0.049	0.02	20.82	21.50	1.169	0.057	22.3
Extremity Test data (Separate 0mm 100%RB)												
Right side	20	QPSK 100_0	132322/1745	1:1	2.440	1.210	0.12	20.40	21.50	1.288	1.559	22.3

8.2.9 SAR Result of LTE Band 71

LTE Band 71 SAR Test Record												
Test position	BW.	Test mode	Test ch./Freq.	Duty Cycle	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data (Separate 0mm 1RB)												
Front side	20	QPSK 1_50	133322/683	1:1	0.119	0.075	0.11	24.12	25.00	1.225	0.092	22.3
Back side	20	QPSK 1_50	133322/683	1:1	0.838	0.349	-0.16	24.12	25.00	1.225	0.427	22.3
Left side	20	QPSK 1_50	133322/683	1:1	0.089	0.054	-0.18	24.12	25.00	1.225	0.066	22.3
Right side	20	QPSK 1_50	133322/683	1:1	0.761	0.445	-0.02	24.12	25.00	1.225	0.545	22.3
Right side-sample 2	20	QPSK 1_50	133322/683	1:1	0.789	0.441	0.01	24.12	25.00	1.225	0.540	22.3
Right side-sample 3	20	QPSK 1_50	133322/683	1:1	0.758	0.424	-0.03	24.12	25.00	1.225	0.519	22.3
Top side	20	QPSK 1_50	133322/683	1:1	0.129	0.080	0.08	24.12	25.00	1.225	0.098	22.3
Bottom side	20	QPSK 1_50	133322/683	1:1	0.023	0.012	0.02	24.12	25.00	1.225	0.015	22.3
Right side-sample 4	20	QPSK 1_50	133322/683	1:1	0.738	0.427	-0.08	24.12	25.00	1.225	0.523	22.3
Right side-sample 5	20	QPSK 1_50	133322/683	1:1	0.750	0.442	-0.01	24.12	25.00	1.225	0.541	22.3
Right side-sample 6	20	QPSK 1_50	133322/683	1:1	0.760	0.444	0.10	24.12	25.00	1.225	0.544	22.3
Extremity Test data (Separate 0mm 50%RB)												
Front side	20	QPSK 50_25	133322/683	1:1	0.096	0.062	0.00	23.17	24.00	1.211	0.075	22.3
Back side	20	QPSK 50_25	133322/683	1:1	0.690	0.287	-0.01	23.17	24.00	1.211	0.347	22.3
Left side	20	QPSK 50_25	133322/683	1:1	0.070	0.043	0.10	23.17	24.00	1.211	0.052	22.3
Right side	20	QPSK 50_25	133322/683	1:1	0.557	0.313	-0.07	23.17	24.00	1.211	0.379	22.3
Top side	20	QPSK 50_25	133322/683	1:1	0.099	0.061	0.18	23.17	24.00	1.211	0.074	22.3
Bottom side	20	QPSK 50_25	133322/683	1:1	0.018	0.010	-0.06	23.17	24.00	1.211	0.012	22.3



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8.2.10 SAR Result of WIFI 2.4G

Wi-Fi 2.4G SAR Test Record												
Test position	Test mode	Test ch./Freq.	Duty Cycle	Duty Cycle Scaled factor	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data												
Front side	802.11b	6/2437	98.57%	1.015	0.169	0.090	-0.01	17.10	18.00	1.230	0.112	22.5
Back side	802.11b	6/2437	98.57%	1.015	0.104	0.061	-0.07	17.10	18.00	1.230	0.076	22.5
Left side	802.11b	6/2437	98.57%	1.015	0.147	0.080	-0.13	17.10	18.00	1.230	0.100	22.5
Right side	802.11b	6/2437	98.57%	1.015	2.180	0.922	0.04	17.10	18.00	1.230	1.151	22.5
Right side-sample 2	802.11b	6/2437	98.57%	1.015	1.640	0.680	0.06	17.10	18.00	1.230	0.849	22.5
Right side-sample 3	802.11b	6/2437	98.57%	1.015	1.920	0.767	0.03	17.10	18.00	1.230	0.957	22.5
Top side	802.11b	6/2437	98.57%	1.015	0.164	0.094	-0.08	17.10	18.00	1.230	0.117	22.5
Bottom side	802.11b	6/2437	98.57%	1.015	0.019	0.010	0.08	17.10	18.00	1.230	0.012	22.5
Right side-sample 4	802.11b	6/2437	98.57%	1.015	1.640	0.680	0.06	17.10	18.00	1.230	0.849	22.5
Right side-sample 5	802.11b	6/2437	98.57%	1.015	1.520	0.638	0.05	17.10	18.00	1.230	0.796	22.5
Right side-sample 6	802.11b	6/2437	98.57%	1.015	1.920	0.801	-0.04	17.10	18.00	1.230	1.000	22.5

8.2.11 SAR Result of WIFI 5G

Wi-Fi 5G SAR Test Record												
Test position	Test mode	Test ch./Freq.	Duty Cycle	Duty Cycle Scaled factor	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test Data of U-NII-2A												
Front side	802.11a	64/5320	98.57%	1.015	0.451	0.182	0.13	16.36	17.00	1.159	0.214	22.4
Back side	802.11a	64/5320	98.57%	1.015	0.248	0.090	-0.06	16.36	17.00	1.159	0.106	22.4
Left side	802.11a	64/5320	98.57%	1.015	0.174	0.040	-0.10	16.36	17.00	1.159	0.047	22.4
Right side	802.11a	64/5320	98.57%	1.015	2.310	0.670	0.09	16.36	17.00	1.159	0.788	22.4
Right side-sample 2	802.11a	64/5320	98.57%	1.015	2.120	0.655	0.17	16.36	17.00	1.159	0.770	22.4
Right side-sample 3	802.11a	64/5320	98.57%	1.015	1.720	0.447	-0.02	16.36	17.00	1.159	0.525	22.4
Top side	802.11a	64/5320	98.57%	1.015	0.474	0.177	0.14	16.36	17.00	1.159	0.208	22.4
Bottom side	802.11a	64/5320	98.57%	1.015	0.085	0.021	0.06	16.36	17.00	1.159	0.025	22.4
Right side-sample 4	802.11a	64/5320	98.57%	1.015	2.230	0.655	-0.03	16.36	17.00	1.159	0.770	22.4
Right side-sample 5	802.11a	64/5320	98.57%	1.015	2.270	0.660	-0.03	16.36	17.00	1.159	0.776	22.4
Right side-sample 6	802.11a	64/5320	98.57%	1.015	2.300	0.665	-0.14	16.36	17.00	1.159	0.782	22.4
Extremity Test Data of U-NII-2C												
Front side	802.11n HT40	134/5670	96.94%	1.032	0.211	0.084	-0.10	16.11	17.00	1.227	0.106	22.4
Back side	802.11n HT40	134/5670	96.94%	1.032	0.159	0.054	-0.11	16.11	17.00	1.227	0.068	22.4
Left side	802.11n HT40	134/5670	96.94%	1.032	0.068	0.018	0.03	16.11	17.00	1.227	0.023	22.4
Right side	802.11n HT40	134/5670	96.94%	1.032	1.360	0.350	-0.01	16.11	17.00	1.227	0.443	22.4
Top side	802.11n HT40	134/5670	96.94%	1.032	0.344	0.129	0.10	16.11	17.00	1.227	0.163	22.4
Bottom side	802.11n HT40	134/5670	96.94%	1.032	0.067	0.017	-0.07	16.11	17.00	1.227	0.022	22.4
Extremity Test Data of U-NII-3												
Front side	802.11a	165/5825	98.10%	1.019	0.364	0.122	0.01	16.05	17.00	1.245	0.155	22.4
Back side	802.11a	165/5825	98.10%	1.019	0.183	0.041	-0.01	16.05	17.00	1.245	0.052	22.4
Left side	802.11a	165/5825	98.10%	1.019	0.088	0.022	0.11	16.05	17.00	1.245	0.028	22.4
Right side	802.11a	165/5825	98.10%	1.019	1.950	0.493	-0.10	16.05	17.00	1.245	0.625	22.4
Top side	802.11a	165/5825	98.10%	1.019	0.498	0.176	0.01	16.05	17.00	1.245	0.223	22.4
Bottom side	802.11a	165/5825	98.10%	1.019	0.080	0.020	0.02	16.05	17.00	1.245	0.025	22.4

8.2.12 SAR Result of BT

Bluetooth SAR Test Record												
Test position	Test mode	Test ch./Freq.	Duty Cycle	Duty Cycle Scaled factor	SAR (W/kg) 1-g	SAR (W/kg) 10-g	Power drift (dB)	Conducted Power(dBm)	Tune up Limit(dBm)	Scaled factor	Scaled SAR 10-g (W/kg)	Liquid Temp.(°C)
Extremity Test data												
Front side	DH5	39/2441	77.07%	1.298	0.049	0.026	0.04	10.50	11.00	1.123	0.038	22.5
Back side	DH5	39/2441	77.07%	1.298	0.030	0.018	0.06	10.50	11.00	1.123	0.026	22.5
Left side	DH5	39/2441	77.07%	1.298	0.043	0.023	-0.13	10.50	11.00	1.123	0.033	22.5
Right side	DH5	39/2441	77.07%	1.298	0.250	0.107	0.09	10.50	11.00	1.123	0.156	22.5
Right side-sample 2	DH5	39/2441	77.07%	1.298	0.227	0.098	0.04	10.50	11.00	1.123	0.143	22.5
Right side-sample 3	DH5	39/2441	77.07%	1.298	0.209	0.087	0.07	10.50	11.00	1.123	0.127	22.5
Top side	DH5	39/2441	77.07%	1.298	0.048	0.027	0.08	10.50	11.00	1.123	0.039	22.5
Bottom side	DH5	39/2441	77.07%	1.298	0.006	0.003	0.04	10.50	11.00	1.123	0.004	22.5
Right side-sample 4	DH5	39/2441	77.07%	1.298	0.230	0.102	-0.11	10.50	11.00	1.123	0.149	22.4
Right side-sample 5	DH5	39/2441	77.07%	1.298	0.241	0.100	-0.02	10.50	11.00	1.123	0.146	22.4
Right side-sample 6	DH5	39/2441	77.07%	1.298	0.246	0.105	-0.10	10.50	11.00	1.123	0.153	22.4

8.3 Multiple Transmitter Evaluation

8.3.1 Simultaneous SAR test evaluation

No.	Simultaneous Tx Combination	Extremity
1	WWAN + WLAN 2.4GHz + WLAN 5GHz	Yes
2	WWAN + WLAN 5GHz + BT	Yes

Note:

- 1) The device does not support DTM function.
- 2) NFC is different from the working scenario of WWAN/WIFI(Extremity) and does not participate in the simultaneous transmission.
- 3) The NFC test data can be referred to NFC SAR test report (Report No.: SZCR250700303708).



8.3.2 Simultaneous Transmission SAR Summation Scenario

0mm:

Test position		SARmax (W/kg)				Summed SAR	
		WWAN MAX SAR	WiFi 2.4G	WiFi 5G	BT		
		1	2	3	4	1+2+3	1+3+4
LTE B7	Front side	0.074	0.112	0.214	0.038	0.400	0.326
	Back side	0.972	0.076	0.106	0.026	1.154	1.104
	Left side	0.060	0.100	0.047	0.033	0.207	0.140
	Right side	1.488	1.151	0.788	0.156	3.427	2.432
	Top side	0.067	0.117	0.223	0.039	0.407	0.329
	Bottom side	0.064	0.012	0.025	0.004	0.101	0.093
LTE B12/17	Front side	0.097	0.112	0.214	0.038	0.423	0.349
	Back side	0.529	0.076	0.106	0.026	0.711	0.661
	Left side	0.124	0.100	0.047	0.033	0.271	0.204
	Right side	0.785	1.151	0.788	0.156	2.724	1.729
	Top side	0.068	0.117	0.223	0.039	0.408	0.330
	Bottom side	0.016	0.012	0.025	0.004	0.053	0.045
LTE B13	Front side	0.216	0.112	0.214	0.038	0.542	0.468
	Back side	0.553	0.076	0.106	0.026	0.735	0.685
	Left side	0.103	0.100	0.047	0.033	0.250	0.183
	Right side	1.098	1.151	0.788	0.156	3.037	2.042
	Top side	0.120	0.117	0.223	0.039	0.460	0.382
	Bottom side	0.022	0.012	0.025	0.004	0.059	0.051
LTE B14	Front side	0.228	0.112	0.214	0.038	0.554	0.480
	Back side	0.524	0.076	0.106	0.026	0.706	0.656
	Left side	0.086	0.100	0.047	0.033	0.233	0.166
	Right side	1.086	1.151	0.788	0.156	3.025	2.030
	Top side	0.118	0.117	0.223	0.039	0.458	0.380
	Bottom side	0.029	0.012	0.025	0.004	0.066	0.058
LTE B25/B2	Front side	0.065	0.112	0.214	0.038	0.391	0.317
	Back side	1.069	0.076	0.106	0.026	1.251	1.201
	Left side	0.169	0.100	0.047	0.033	0.316	0.249
	Right side	1.993	1.151	0.788	0.156	3.932	2.937
	Top side	0.039	0.117	0.223	0.039	0.379	0.301
	Bottom side	0.101	0.012	0.025	0.004	0.138	0.130
LTE B26/B5	Front side	0.164	0.112	0.214	0.038	0.490	0.416
	Back side	0.494	0.076	0.106	0.026	0.676	0.626
	Left side	0.066	0.100	0.047	0.033	0.213	0.146
	Right side	1.087	1.151	0.788	0.156	3.026	2.031
	Top side	0.287	0.117	0.223	0.039	0.627	0.549
	Bottom side	0.043	0.012	0.025	0.004	0.080	0.072
LTE B41	Front side	0.048	0.112	0.214	0.038	0.374	0.300
	Back side	0.508	0.076	0.106	0.026	0.690	0.640
	Left side	0.034	0.100	0.047	0.033	0.181	0.114
	Right side	0.743	1.151	0.788	0.156	2.682	1.687
	Top side	0.044	0.117	0.223	0.039	0.384	0.306
	Bottom side	0.024	0.012	0.025	0.004	0.061	0.053



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LTE B66/B4	Front side	0.102	0.112	0.214	0.038	0.428	0.354
	Back side	0.553	0.076	0.106	0.026	0.735	0.685
	Left side	0.131	0.100	0.047	0.033	0.278	0.211
	Right side	2.034	1.151	0.788	0.156	3.973	2.978
	Top side	0.042	0.117	0.223	0.039	0.382	0.304
	Bottom side	0.086	0.012	0.025	0.004	0.123	0.115
LTE B71	Front side	0.092	0.112	0.214	0.038	0.418	0.344
	Back side	0.427	0.076	0.106	0.026	0.609	0.559
	Left side	0.066	0.100	0.047	0.033	0.213	0.146
	Right side	0.545	1.151	0.788	0.156	2.484	1.489
	Top side	0.098	0.117	0.223	0.039	0.438	0.360
	Bottom side	0.015	0.012	0.025	0.004	0.052	0.044



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9 Equipment list

Test Platform		SPEAG DASY Professional				
Description		SAR Test System				
Software Reference		DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)				
Hardware Reference						
Equipment		Manufacturer	Model	Inventory No.	Calibration Date	Due date of calibration
☒	Test Phantom	SPEAG	SAM Twin	SZ-WSR-A-023	NCR	NCR
☒	Test Phantom	SPEAG	SAM Twin	SZ-WSR-A-025	NCR	NCR
☒	DAE	SPEAG	DAE4	SZ-WSR-M-028	2025/04/27	2026/04/26
☒	DAE	SPEAG	DAE4	SZ-WSR-M-031	2025/03/27	2026/03/26
☒	E-Field Probe	SPEAG	EX3DV4	SZ-WSR-M-068	2025/01/15	2026/01/14
☒	E-Field Probe	SPEAG	ES3DV3	SZ-WSR-R-021	2024/12/10	2025/12/09
☒	Validation Kits	SPEAG	D750V3	SZ-WSR-M-032	2025/06/18	2028/06/17
☒	Validation Kits	SPEAG	D835V2	SZ-WSR-M-033	2022/11/02	2025/11/01
☒	Validation Kits	SPEAG	D1750V2	SZ-WSR-M-035	2025/06/18	2028/06/17
☒	Validation Kits	SPEAG	D1900V2	SZ-WSR-M-036	2022/11/02	2025/11/01
☒	Validation Kits	SPEAG	D2450V2	SZ-WSR-M-039	2022/11/02	2025/11/01
☒	Validation Kits	SPEAG	D2600V2	SZ-WSR-M-040	2025/06/17	2028/06/16
☒	Validation Kits	SPEAG	D5GHzV2	SZ-WSR-M-046	2022/11/01	2025/10/31
☒	Dielectric parameter probes	SPEAG	DAK-3.5	SZ-WSR-M-093	2024/11/18	2025/11/17
☒	Agilent Network Analyzer	Agilent	E5071C	SZ-WSR-M-067	2024/12/19	2025/12/18
☒	RF Bi-Directional Coupler	Agilent	86205-60001	SZ-WSR-A-004	NCR	NCR
☒	Signal Generator	Agilent	N5171B	SZ-WSR-M-006	2025/01/07	2026/01/06
☒	Preamplifier	Mini-Circuits	ZHL-42W	SZ-WSR-A-001	NCR	NCR
☒	Preamplifier	Compliance Directions Systems Inc.	AMP28-3W	SZ-WSR-A-002	NCR	NCR
☒	Power Meter	Agilent	E4416A	SZ-WSR-M-007	2025/01/07	2026/01/06
☒	Power Sensor	Agilent	8481H	SZ-WSR-M-008	2025/01/07	2026/01/06
☒	Power Sensor	R&S	NRP-Z92	SZ-WSR-M-009	2025/01/08	2026/01/07
☒	Attenuator	SHX	TS2-3dB	SZ-WSR-A-012	NCR	NCR
☒	Speed reading thermometer	Zhengzhou Boyang Instrument	TP3001	SZ-WSR-M-014	2025/05/19	2026/05/18
☒	Temperature	MingGao	T809	SZ-WSR-M-015	2025/05/19	2026/05/18
☒	Temperature	MingGao	T809	SZ-WSR-M-016	2025/05/19	2026/05/18
☒	Humidity and Temperature Indicator	CHIGAO	HTC-1	SZ-WSR-M-012	2025/05/16	2026/05/15

Note: All the equipment are within the valid period when the tests are performed.



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10 Calibration certificate

Please see the Appendix C

11 Photographs

Please see the Appendix D

Appendix A: Detailed System Check Results

Appendix B: Detailed Test Results

Appendix C: Calibration certificate

Appendix D: Photographs

Appendix E: Conducted RF Output Power

--- End of report ---



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